


<b>Search Notes</b>  	<b>Application/Control No.</b>  10715187	<b>Applicant(s)/Patent Under Reexamination</b>  FINKE-ANLAUFF ET AL.
	<b>Examiner</b>  Tan, Alvin H	<b>Art Unit</b>  2173

SEARCHED			
Class	Subclass	Date	Examiner
715	963	4/10/08 (Updated 3/27/09)	/AT/ (/AT/)

SEARCH NOTES		
Search Notes	Date	Examiner
715/719, 721 (text search only - see search history printout)	4/10/08	/AT/
707/3 (text search only - see search history printout)	4/10/08	/AT/
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	4/10/08	/AT/
Above - UPDATED	3/27/09	/AT/
NPL (Google.com)	4/10/08	/AT/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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